33976 measured reflections

 $R_{\rm int} = 0.038$

1723 independent reflections

1517 reflections with $I > 2\sigma(I)$

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2-[(Methoxycarbonothioyl)sulfanyl]acetic acid

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Key indicators: single-crystal X-ray study; T = 150 K; mean σ (C–C) = 0.002 Å; R factor = 0.021; wR factor = 0.056; data-to-parameter ratio = 20.5.

The title compound, $C_4H_6O_3S_2$, features a characteristic xanthate group; the C=S double bond is shorter than the C-S single bond, and the methyl group is coplanar with the xanthate group. In the crystal pairs of molecules form dimers through intermolecular O-H···O hydrogen bonding.

Related literature

For a related structure, see: Xiao & Charpentier (2010). For the design and applications of the title compound, see: Moad *et al.* (2005, 2008); Stenzel *et al.* (2003); Coote & Radom (2004); Coote *et al.* (2006).



Experimental

Crystal data

$C_4H_6O_3S_2$
$M_r = 166.21$
Monoclinic, $P2_1/c$
a = 7.1009 (3) Å
b = 10.6485 (5)Å
c = 9.2022 (4) Å
$\beta = 93.370 \ (1)^{\circ}$

$V = 694.61 (5) \text{ Å}^3$	
Z = 4	
Mo Ka radiation	
$\mu = 0.70 \text{ mm}^{-1}$	
T = 150 K	
$0.10 \times 0.07 \times 0.06 \text{ mm}$	n

Data collection

Bruker APEXII CCD

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diffractometer
Absorption correction: multi-scan
(SADABS; Sheldrick, 1996)
T_{\min} = 0.931, T_{\max} = 0.963
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Refinement

$R[F^2 > 2\sigma(F^2)] = 0.021$	84 parameters
$wR(F^2) = 0.056$	H-atom parameters constrained
S = 1.05	$\Delta \rho_{\rm max} = 0.29 \text{ e } \text{\AA}^{-3}$
1723 reflections	$\Delta \rho_{\rm min} = -0.20 \text{ e } \text{\AA}^{-3}$

Table 1

Hydrogen-bond geometry (Å, °).

$D - H \cdots A$	$D-\mathrm{H}$	$H \cdot \cdot \cdot A$	$D \cdots A$	$D - \mathbf{H} \cdots A$		
$O2-H2\cdots O3^i$	0.84	1.82	2.6540 (12)	175		
Symmetry code: (i) $-x + 1, -y, -z + 2$.						

Data collection: *APEX2* (Bruker, 2009); cell refinement: *SAINT* (Bruker, 2009); data reduction: *SAINT*; program(s) used to solve structure: *SHELXS97* (Sheldrick, 2008); program(s) used to refine structure: *SHELXL97* (Sheldrick, 2008); molecular graphics: *SHELXTL* (Sheldrick, 2008); software used to prepare material for publication: *SHELXTL*.

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Supplementary data and figures for this paper are available from the IUCr electronic archives (Reference: NG5085).

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supplementary materials

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2-[(Methoxycarbonothioyl)sulfanyl]acetic acid

S. Xiao and P. A. Charpentier

Comment

Carbonothioylthio (S=C—S) compounds are used as chain transfer agents (CTA) in addition-fragmentation chain-transfer (RAFT) polymerization. In the addition-fragmentation equilibria, addition of the propagating radicals to the S=C group followed by fragmentation of the intermediate radical at the C—S bond generates a new radical and a polymeric carbonothioyl-thio compound (Moad *et al.*, 2005, 2008). *O*-alkyl xanthates show low reactivity in RAFT equilibria due to the conjugation of the *O* lone pair electrons and the C=S bond which is favorable to the zwitterionic canonical forms of xanthates (Moad *et al.*, 2005; Coote *et al.*, 2006). However, xanthates can promote fragmentation of unstable radicals, such as vinyl acetate radicals that undergo fast addition and slow fragmentation (Coote *et al.*, 2006). Though studies have been done on RAFT polymerization of vinyl acetate with methyl 2-(methoxycarbonothioylthio)acetic acid has not been used in RAFT polymerization. Therefore, efforts were made to use 2-(methoxycarbonothioylthio)acetic acid as the CTA in RAFT polymerization, and poly(vinyl acetate)s containing carboxylic acid end groups were successfully prepared. A similar compound, 2-(isopropoxycarbonothioylthio)acetic acid, has been reported for the same application (Xiao & Charpentier, 2010).

Experimental

Potassium hydroxide 5.6 g (50 mmol) was dissolved in methanol 30 ml at room temperature. The solution was cooled with an ice bath when carbon disulfide 20 ml was charged into the flask dropwise. After 1 day reaction at room temperature, a solution of 2-bromoacetic acid 6.9 g (50 mmol) / methanol 20 ml was added into the flask dropwise in an ice bath. The precipitates were removed by filtration after 2 days reaction at room temperature, and the solvent was evaporated with a rotary evaporator. The crude product was run through a silica gel column with a mixture of ethyl ether / hexanes (5:1). Colorless crystals were obtained from crystalization in hexanes/ cyclohexane (4:1). m.p.: 112.6 °C (DSC). MS: 165.9764.

Refinement

The structure was solved and refined using the Bruker *SHELXTL* Software Package, using the space group P 1 21/c 1, with Z = 4 for the formula unit, C₄H₆O₃S₂. All of the non-hydrogen atoms were refined with anisotropic thermal parameters. The hydrogen atom positions were calculated geometrically and were included as riding on their respective carbon/oxygen atoms. The final anisotropic full-matrix least-squares refinement on F² with 84 variables converged at R1 = 2.13%, for the observed data and wR2 = 5.55% for all data. The goodness-of-fit was 1.047. The largest peak in the final difference electron density synthesis was 0.288 e⁻/Å³ and the largest hole was -0.195 e⁻/Å³ with an RMS deviation of 0.040 e⁻/Å³. On the basis of the final model, the calculated density was 1.589 g/cm³ and F(000), 344 e⁻.

Figures



Fig. 1. View of the title compound (50% probability displacement ellipsoids).

Fig. 2. Packing diagram of the structure with H-bonds.

2-[(Methoxycarbonothioyl)sulfanyl]acetic acid

Crystal data	
$C_4H_6O_3S_2$	F(000) = 344
$M_r = 166.21$	$D_{\rm x} = 1.589 {\rm ~Mg~m}^{-3}$
Monoclinic, $P2_1/c$	Mo <i>K</i> α radiation, $\lambda = 0.71073$ Å
Hall symbol: -P 2ybc	Cell parameters from 9941 reflections
a = 7.1009 (3) Å	$\theta = 2.9 - 30.2^{\circ}$
b = 10.6485 (5) Å	$\mu = 0.70 \text{ mm}^{-1}$
c = 9.2022 (4) Å	T = 150 K
$\beta = 93.370 \ (1)^{\circ}$	Block, colourless
$V = 694.61 (5) \text{ Å}^3$	$0.10\times0.07\times0.06~mm$
Z = 4	

Data collection

Bruker APEXII CCD diffractometer	1723 independent reflections
Radiation source: fine-focus sealed tube	1517 reflections with $I > 2\sigma(I)$
graphite	$R_{\rm int} = 0.038$
ϕ and ω scans	$\theta_{\text{max}} = 28.3^{\circ}, \ \theta_{\text{min}} = 2.9^{\circ}$
Absorption correction: multi-scan (SADABS; Sheldrick, 1996)	$h = -9 \rightarrow 9$
$T_{\min} = 0.931, T_{\max} = 0.963$	$k = -14 \rightarrow 13$
33976 measured reflections	$l = -12 \rightarrow 12$

Refinement

Refinement on F^2	
Least-squares matrix: full	
$R[F^2 > 2\sigma(F^2)] = 0.021$	

Primary atom site location: structure-invariant direct methods Secondary atom site location: difference Fourier map Hydrogen site location: inferred from neighbouring sites

$wR(F^2) = 0.056$	H-atom parameters constrained
<i>S</i> = 1.05	$w = 1/[\sigma^2(F_o^2) + (0.0234P)^2 + 0.2541P]$ where $P = (F_o^2 + 2F_c^2)/3$
1723 reflections	$(\Delta/\sigma)_{\text{max}} = 0.001$
84 parameters	$\Delta \rho_{max} = 0.29 \text{ e} \text{ Å}^{-3}$
0 restraints	$\Delta \rho_{min} = -0.20 \text{ e } \text{\AA}^{-3}$

Special details

Geometry. All e.s.d.'s (except the e.s.d. in the dihedral angle between two l.s. planes) are estimated using the full covariance matrix. The cell e.s.d.'s are taken into account individually in the estimation of e.s.d.'s in distances, angles and torsion angles; correlations between e.s.d.'s in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell e.s.d.'s is used for estimating e.s.d.'s involving l.s. planes.

Refinement. Refinement of F^2 against ALL reflections. The weighted *R*-factor *wR* and goodness of fit *S* are based on F^2 , conventional *R*-factors *R* are based on *F*, with *F* set to zero for negative F^2 . The threshold expression of $F^2 > \sigma(F^2)$ is used only for calculating *R*-factors(gt) *etc*. and is not relevant to the choice of reflections for refinement. *R*-factors based on F^2 are statistically about twice as large as those based on *F*, and *R*- factors based on ALL data will be even larger.

Fractional atomic coordinates and isotropic or equivalent isotropic displacement parameters (A^2)

	x	У	Ζ	$U_{\rm iso}*/U_{\rm eq}$
S1	0.15918 (5)	0.31498 (3)	0.78725 (4)	0.02980 (9)
S2	-0.11784 (5)	0.12843 (3)	0.90015 (4)	0.03122 (9)
01	-0.10815 (13)	0.37609 (8)	0.93394 (10)	0.0311 (2)
O2	0.41851 (14)	-0.01297 (9)	0.81022 (10)	0.0319 (2)
H2	0.4754	-0.0511	0.8797	0.048*
O3	0.38409 (12)	0.13435 (8)	0.98001 (9)	0.02570 (19)
C1	-0.2814 (2)	0.36782 (14)	1.00825 (15)	0.0354 (3)
H1A	-0.3839	0.3404	0.9395	0.053*
H1B	-0.3120	0.4504	1.0476	0.053*
H1C	-0.2659	0.3070	1.0880	0.053*
C2	-0.03785 (16)	0.27021 (11)	0.88181 (13)	0.0233 (2)
C3	0.25018 (18)	0.16615 (12)	0.73538 (13)	0.0279 (3)
H3A	0.1438	0.1134	0.6969	0.034*
H3B	0.3354	0.1794	0.6554	0.034*
C4	0.35645 (16)	0.09552 (11)	0.85644 (13)	0.0224 (2)

Atomic displacement parameters $(Å^2)$

	U^{11}	U ²²	U^{33}	U^{12}	U^{13}	U^{23}
S1	0.03072 (17)	0.02100 (15)	0.03800 (18)	0.00050 (12)	0.00457 (13)	0.00871 (12)
S2	0.03306 (17)	0.02151 (16)	0.03927 (19)	-0.00432 (12)	0.00377 (13)	0.00243 (12)
01	0.0293 (5)	0.0230 (4)	0.0407 (5)	0.0011 (3)	0.0005 (4)	-0.0062 (4)
O2	0.0404 (5)	0.0291 (5)	0.0252 (4)	0.0120 (4)	-0.0050 (4)	-0.0049 (4)
O3	0.0264 (4)	0.0255 (4)	0.0248 (4)	0.0046 (3)	-0.0011 (3)	-0.0034 (3)
C1	0.0337 (7)	0.0385 (7)	0.0339 (7)	0.0061 (6)	0.0026 (6)	-0.0058 (6)

supplementary materials

C2	0.0245 (6)	0.0223 (6)	0.0224 (5))	0.0007 (4)	-0.0060 (4)	0.0009 (4)	
C3	0.0317 (6)	0.0281 (6)	0.0242 (6))	0.0041 (5)	0.0040 (5)		0.0041 (5)	
C4	0.0195 (5)	0.0226 (5)	0.0254 (6))	-0.0001 (4)	0.0040 (4)		0.0005 (4)	
Geometric parar	neters (Å, °)								
S1—C2		1.7564 (13)	(03—C4			1.2150	(14)	
S1—C3		1.7870 (13)		С1—Н1	4		0.9800		
S2—C2		1.6253 (12)	(С1—Н11	В		0.9800		
O1—C2		1.3336 (15)	(C1—H10	С		0.9800		
O1—C1		1.4451 (17)	(С3—С4			1.5091	(16)	
O2—C4		1.3159 (14)	(С3—Н3	A		0.9900		
O2—H2		0.8400	(С3—Н3В 0.99		0.9900			
C2—S1—C3		101.69 (6)	:	S2—C2-	—S1		126.65	(7)	
C2		117.76 (10)	C4—C3—S1		114.70 (9)		(9)		
C4—O2—H2		109.5	С4—С3—Н3А			108.6			
O1-C1-H1A		109.5	S1—C3—H3A			108.6			
O1-C1-H1B		109.5		C4—C3—H3B			108.6		
H1A—C1—H1B		109.5	:	S1—C3—H3B		S1—C3—H3B 108.0		108.6	
01—C1—H1C		109.5	НЗА—СЗ—НЗВ		НЗА—СЗ—НЗВ		107.6		
H1A—C1—H1C		109.5	O3—C4—O2			124.23	(11)		
H1B—C1—H1C		109.5	O3—C4—C3		O3—C4—C3		124.58	(11)	
O1—C2—S2		127.40 (10)	O2—C4—C3		C3 111.18 (1		(10)		
O1—C2—S1		105.94 (8)							
Hydrogen-bond	geometry (Å, °)								
D—H···A		I	О—Н	H	··· <i>A</i>	$D \cdots A$		D—H…A	
O2—H2···O3 ⁱ		C).84	1.3	82	2.6540 (12)		175	

Symmetry codes: (i) -x+1, -y, -z+2.



Fig. 1



